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Bailey et al.

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(54) **TEST DEVICE**

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(51) **LOC (14) Cl.** **24-02**

(52) **U.S. Cl.**
USPC **D24/224**

(58) **Field of Classification Search**
USPC D24/121–123, 117, 224; 604/329, 317,
604/318, 334; 600/573, 574; 4/450–460,
4/144.1–144.4, DIG. 5
CPC A61G 9/006; A61G 9/003
See application file for complete search history.

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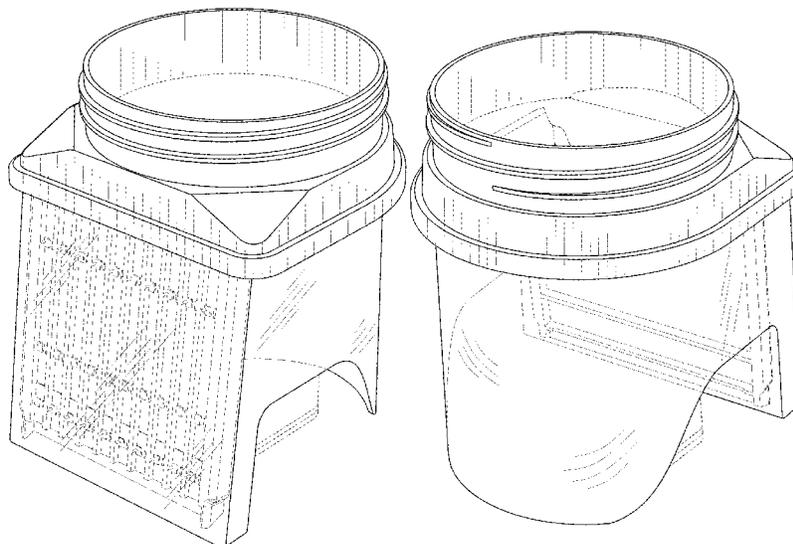
(57) **CLAIM**

The ornamental design for a test device, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of the test device according to the present design, wherein the test device does not have a cap;
FIG. 2 is another perspective view of the test device of FIG. 1;
FIG. 3 is a top view of the test device of FIG. 1;
FIG. 4 is a bottom view of the test device of FIG. 1;
FIG. 5 is a right view of the test device of FIG. 1;
FIG. 6 is a left view of the test device of FIG. 1;
FIG. 7 is a front view of the test device of FIG. 1; and,
FIG. 8 is a rear view of the test device of FIG. 1.
The broken lines show portions of the test device that form no part of the claimed design.

1 Claim, 8 Drawing Sheets



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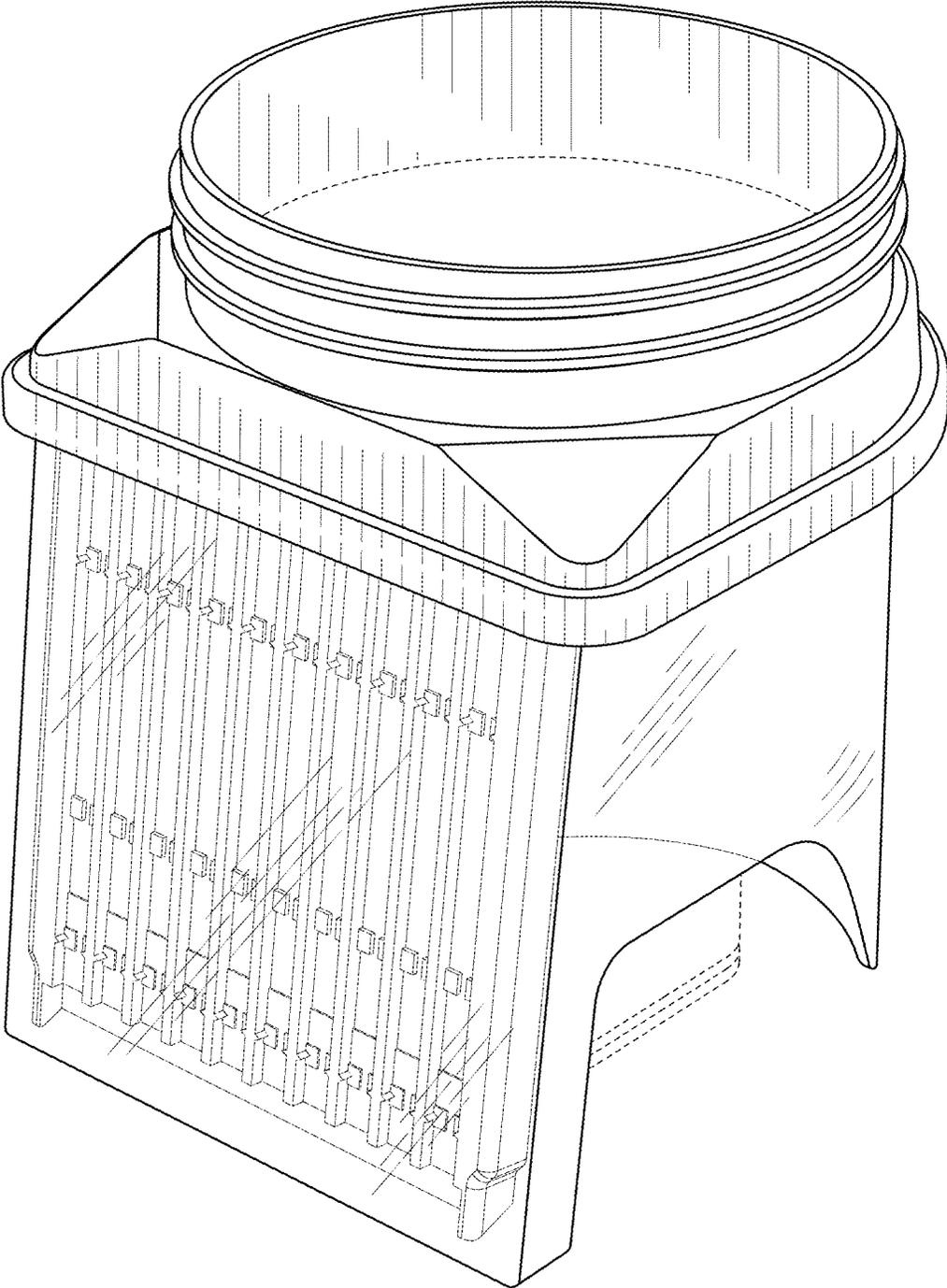


FIG. 1



FIG. 2

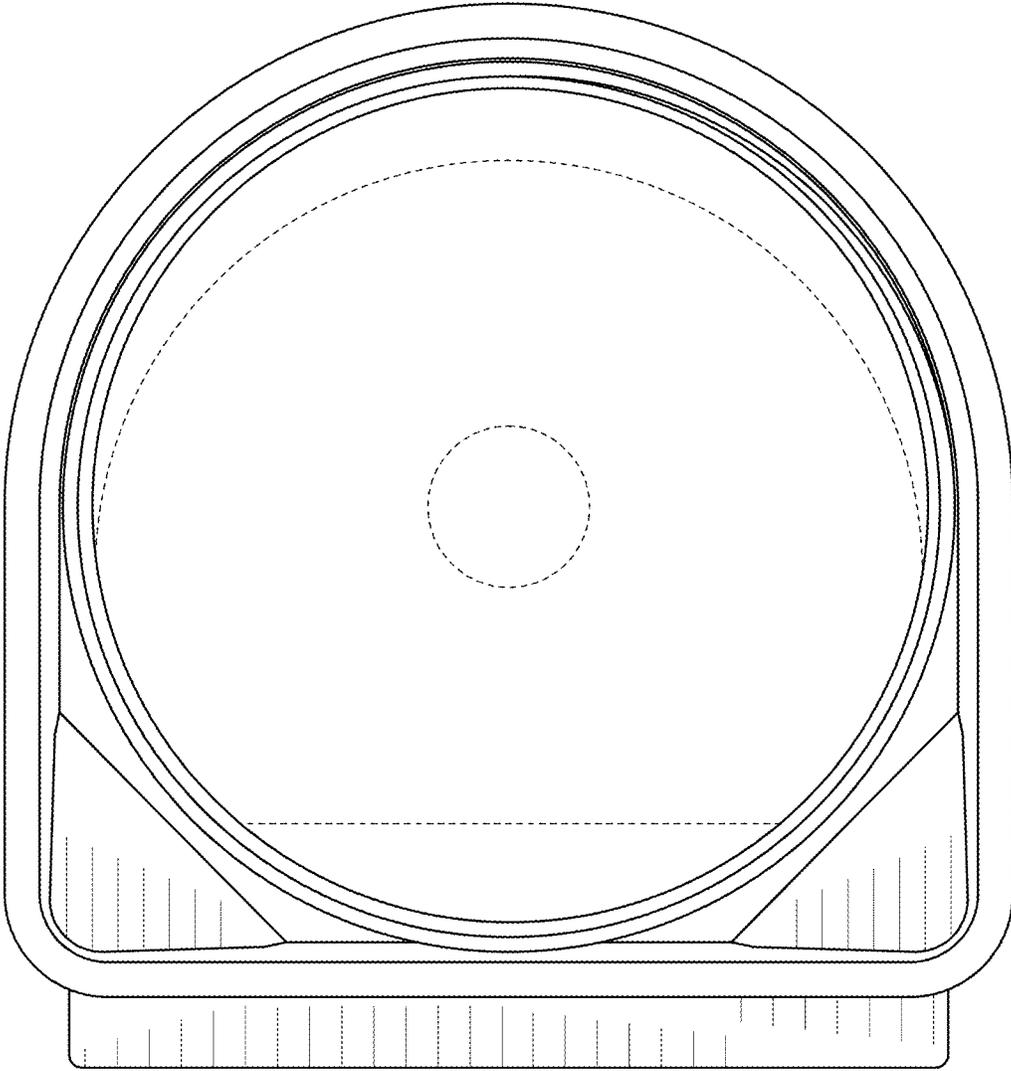


FIG. 3

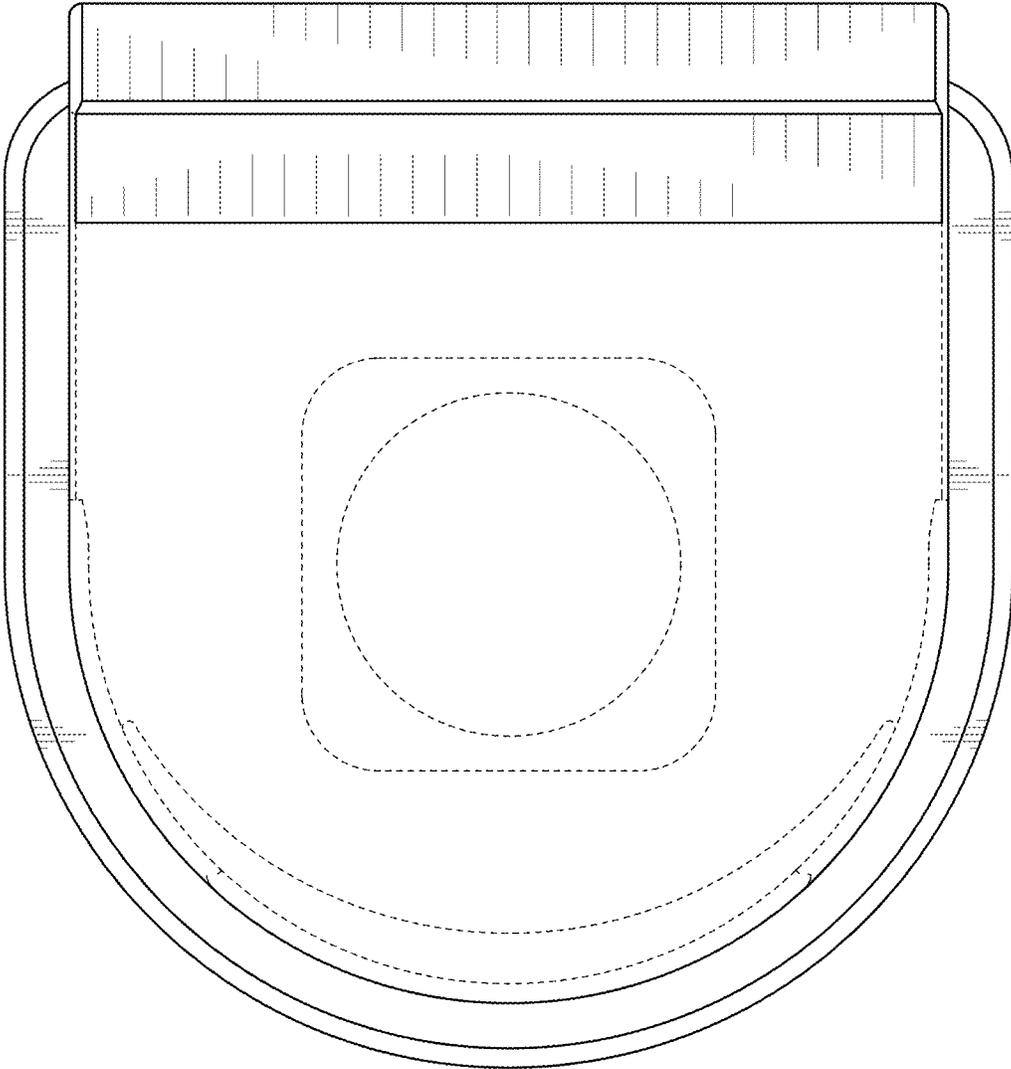


FIG. 4

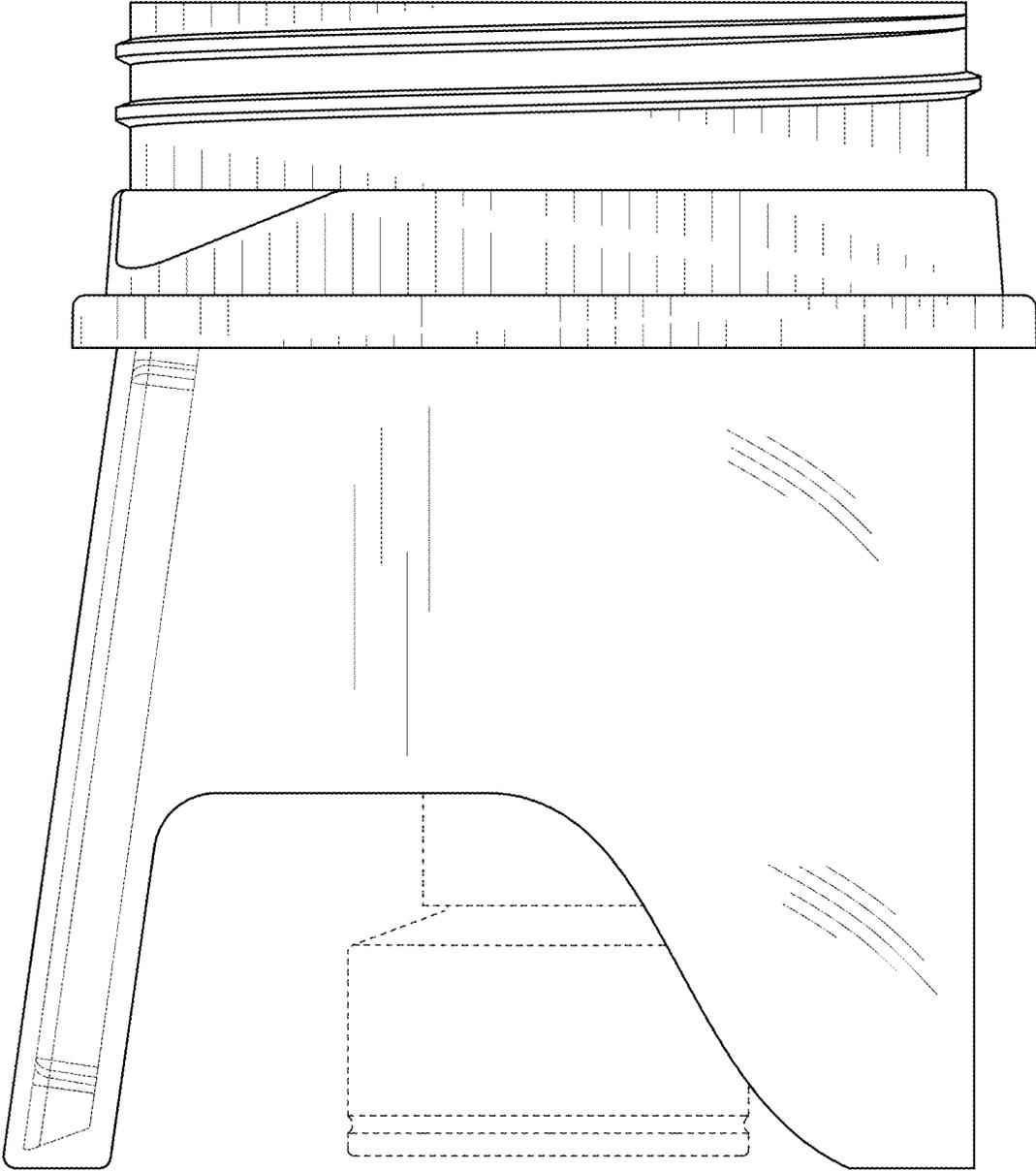


FIG. 5

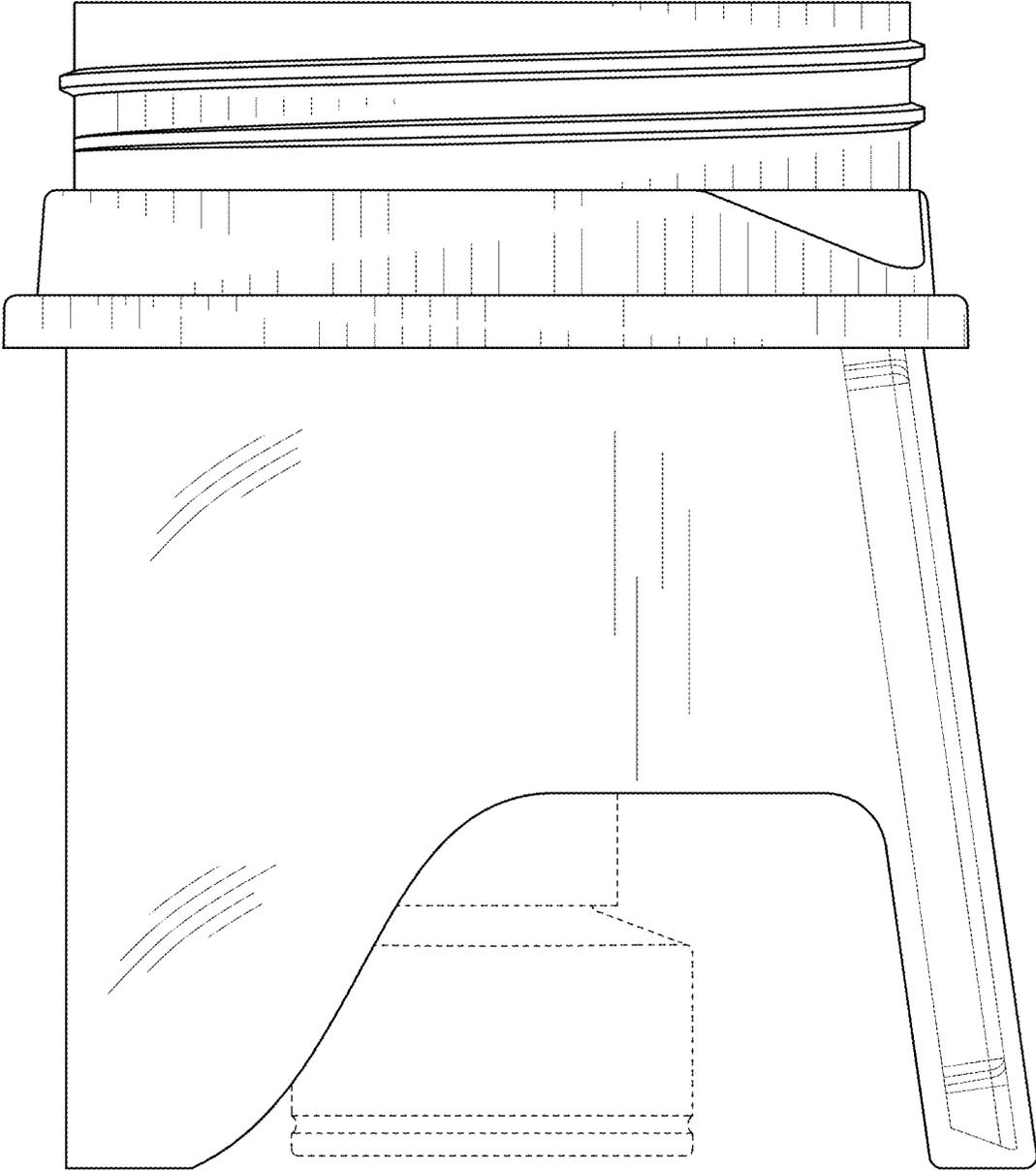


FIG. 6

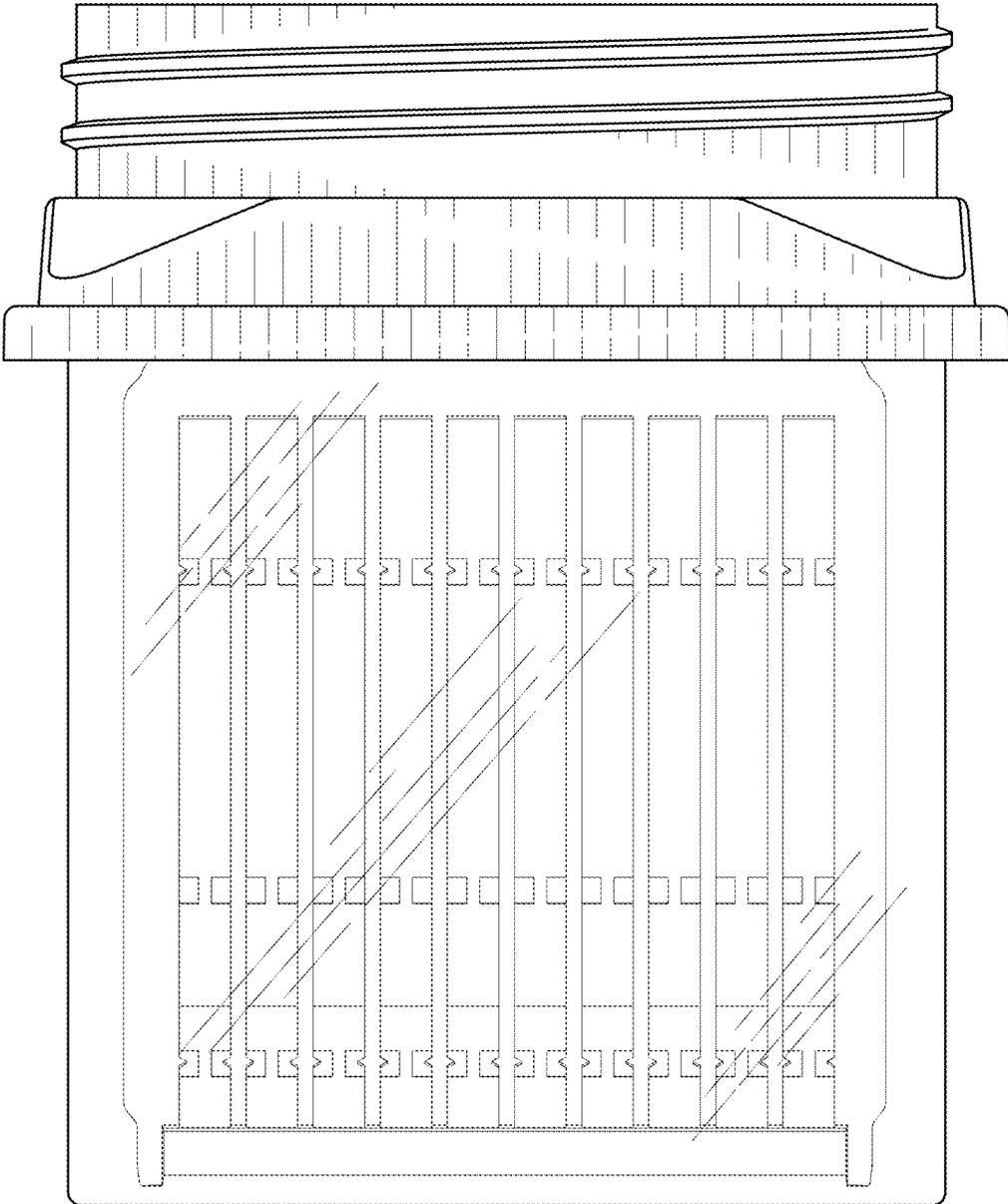


FIG. 7

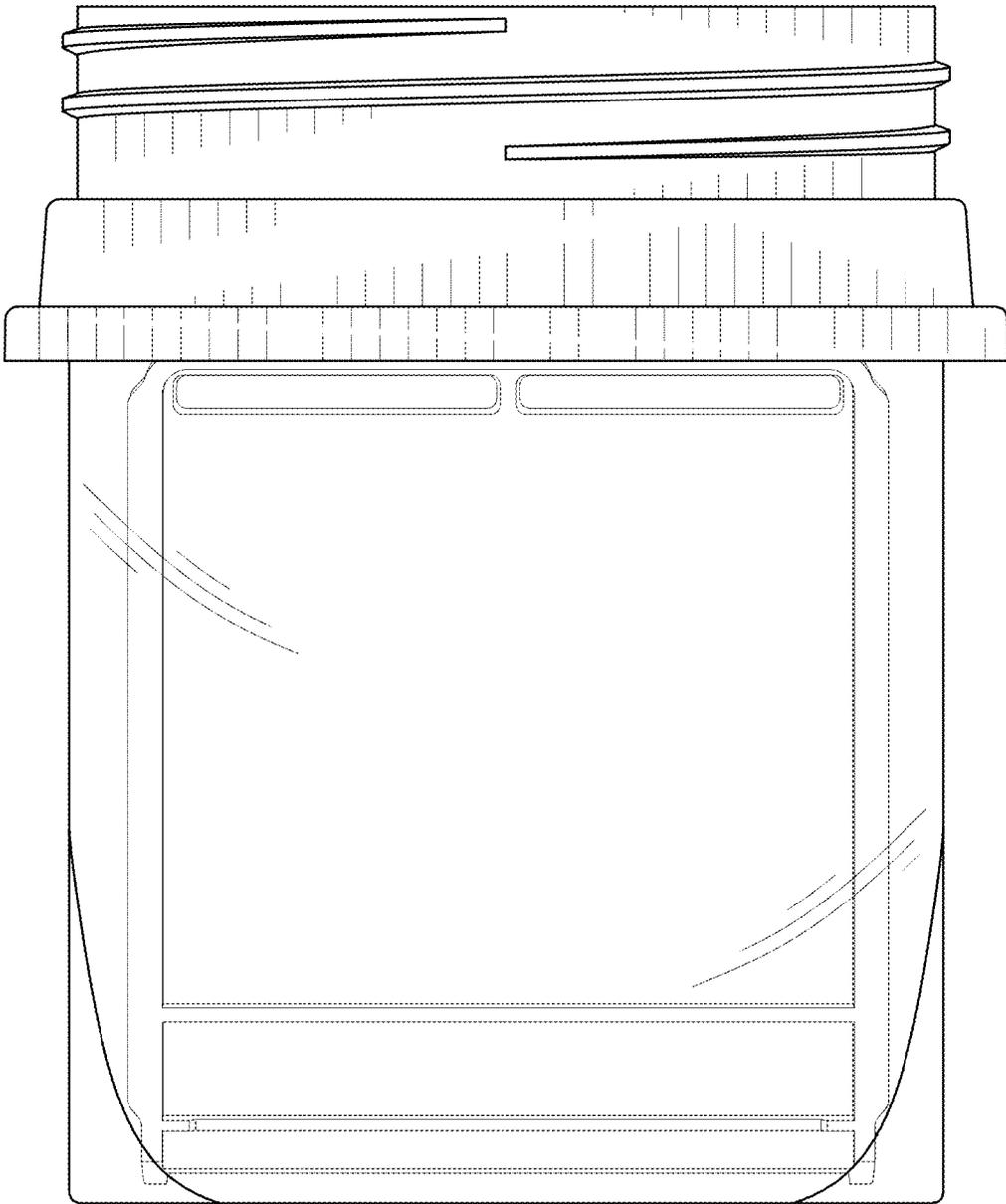


FIG. 8